

PRODUCT SPECIFICATION

Product Description

Peregrine's PE9601 is a high performance integer-N PLL capable of frequency synthesis up to 2.2 GHz. The device is designed for superior phase noise performance while providing an order of magnitude reduction in current consumption, when compared with existing commercial space PLLs.

The PE9601 features a 10/11 dual modulus prescaler, counters and a phase comparator as shown in Figure 1. Counter values are programmable through either a serial or parallel interface and can also be directly hard wired.

The PE9601 is optimized for commercial space applications. Single Event Latch up (SEL) is physically impossible and Single Event Upset (SEU) is better than 10⁻⁹ errors per bit/day. Fabricated in Peregrine's patented UTSi® (Ultra Thin Silicon) CMOS technology, the PE9601 offers excellent RF performance and intrinsic radiation tolerance.

PE9601

2.2 GHz Integer-N PLL for Rad Hard Applications

Features

- 2.2 GHz operation
- 10/11 prescaler
- Internal phase detector with charge pump
- Serial, parallel or hardwired programmable
- Low power 25 mA at 3 V
- Targeted at Q3236 PLL replacement
- 100 Krad total dose
- 44-lead CLCC

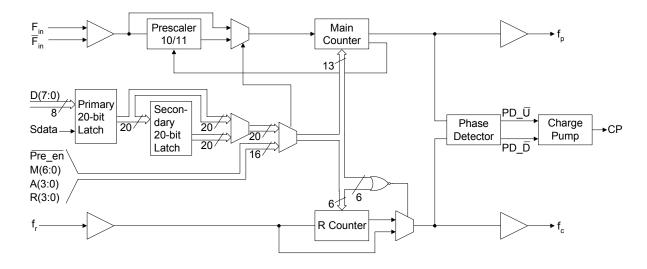


Figure 1. Block Diagram



Figure 2. Pin Configuration

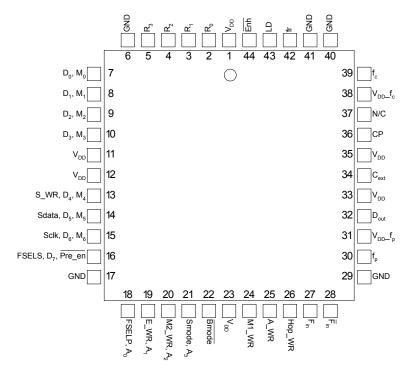


Table 1. Pin Descriptions

Pin No.	Pin Name	Interface Mode	Туре	Description
1	V _{DD}	ALL	(Note 1)	Power supply input. Input may range from 2.85 V to 3.15 V. Bypassing recommended.
2	R ₀	Direct	Input	R Counter bit0 (LSB).
3	R ₁	Direct	Input	R Counter bit1.
4	R ₂	Direct	Input	R Counter bit2.
5	R ₃	Direct	Input	R Counter bit3.
6	GND	ALL	(Note 1)	Ground.
7	D ₀	Parallel	Input	Parallel data bus bit0 (LSB).
7	Mo	Direct	Input	M Counter bit0 (LSB).
8	D ₁	Parallel	Input	Parallel data bus bit1.
	M ₁	Direct	Input	M Counter bit1.
9	D ₂	Parallel	Input	Parallel data bus bit2.
	M ₂	Direct	Input	M Counter bit2.
10	D ₃	Parallel	Input	Parallel data bus bit3.
	M ₃	Direct	Input	M Counter bit3.
11	V _{DD}	ALL	(Note 1)	Same as pin 1.
12	V _{DD}	ALL	(Note 1)	Same as pin 1.



Pin No.	Pin Name	Interface Mode	Туре	Description
13	S_WR	Serial	Input	Serial load enable input. While S_WR is "low", Sdata can be serially clocked. Primary register data are transferred to the secondary register on S_WR or Hop_WR rising edge.
10	D ₄	Parallel	Input	Parallel data bus bit4
	M ₄	Direct	Input	M Counter bit4
	Sdata	Serial	Input	Binary serial data input. Input data entered MSB first.
14	D ₅	Parallel	Input	Parallel data bus bit5.
	M ₅	Direct	Input	M Counter bit5.
	Sclk	Serial	Input	Serial clock input. Sdata is clocked serially into the 20-bit primary register (E_WR "low") or the 8-bit enhancement register (E_WR "high") on the rising edge of Sclk.
15	D ₆	Parallel	Input	Parallel data bus bit6.
	M ₆	Direct	Input	M Counter bit6.
	FSELS	Serial	Input	Selects contents of primary register (FSELS=1) or secondary register (FSELS=0) for programming of internal counters while in Serial Interface Mode.
16	D ₇	Parallel	Input	Parallel data bus bit7 (MSB).
	Pre_en	Direct	Input	Prescaler enable, active "low". When "high", F _{in} bypasses the prescaler.
17	GND	ALL		Ground.
18	FSELP	Parallel	Input	Selects contents of primary register (FSELP=1) or secondary register (FSELP=0) for programming of internal counters while in Parallel Interface Mode.
	A ₀	Direct	Input	A Counter bit0 (LSB).
		Serial	Input	Enhancement register write enable. While E_WR is "high", Sdata can be serially clocked into the enhancement register on the rising edge of Sclk.
19	E_WR	Parallel	Input	Enhancement register write. D[7:0] are latched into the enhancement register on the rising edge of E_WR.
	A ₁	Direct	Input	A Counter bit1.
20	M2_WR	Parallel	Input	M2 write. D[3:0] are latched into the primary register (R[5:4], M[8:7]) on the rising edge of M2_WR.
	A ₂	Direct	Input	A Counter bit2.
21	Smode	Serial, Parallel	Input	Selects serial bus interface mode (Bmode=0, Smode=1) or Parallel Interface Mode (Bmode=0, Smode=0).
	A ₃	Direct	Input	A Counter bit3 (MSB).
22	Bmode	ALL	Input	Selects direct interface mode (Bmode=1).
23	V _{DD}	ALL	(Note 1)	Same as pin 1.
24	M1_WR	Parallel	Input	M1 write. D[7:0] are latched into the primary register (Pre_en, M[6:0]) on the rising edge of M1_WR.
25	A_WR	Parallel	Input	A write. D[7:0] are latched into the primary register (R[3:0], A[3:0]) on the rising edge of A_WR.
26	Hop_WR	Serial, Parallel	Input	Hop write. The contents of the primary register are latched into the secondary register on the rising edge of Hop_WR.
27	F _{in}	ALL	Input	Prescaler input from the VCO. Input voltage = 223 mV RMS for guaranteed operation.
28	\overline{F}_{in}	ALL	Input	Prescaler complementary input. A bypass capacitor should be placed as close as possible to this pin and be connected directly to the ground plane.
29	GND	ALL		Ground.

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Pin No.	Pin Name	Interface Mode	Туре	Description
30	fp	ALL	Output	Monitor pin for main divider output. Switching activity can be disabled through enhancement register programming or by floating or grounding V_{DD} pin 31.
31	V _{DD} -f _c	ALL	(Note 2)	V_{DD} for f_c .
32	Dout	Serial, Parallel	Output	Data Out. The MSEL signal and the raw prescaler output are available on Dout through enhancement register programming.
33	V _{DD}	ALL	(Note 1)	Same as pin 1.
34	Cext	ALL	Output	Logical "OR" of PD_U and PD_D terminated through an on chip, $2 k\Omega$ series resistor. Connecting Cext to an external capacitor will low pass filter the input to the inverting amplifier used for driving LD.
35	V _{DD}	ALL	(Note 1)	Same as pin 1.
36	СР	ALL	Output	Charge pump current is sourced for "up" when f_c leads f_p and sinked for "down" when f_c lags $f_p.$
37	NC	ALL		No connection.
38	V _{DD} -f _p	ALL	(Note 2)	V_{DD} for f_p
39	f _c	ALL	Output	Monitor pin for reference divider output. Switching activity can be disabled through enhancement register programming or by floating or grounding V_{DD} pin 38.
40	GND	ALL		Ground.
41	GND	ALL		Ground.
42	f _r	ALL	Input	Reference frequency input. See figure 3.
43	LD	ALL	Output, OD	Lock detect and open drain logical inversion of Cext. When the loop is in lock, LD is high impedance, otherwise LD is a logic low ("0").
44	Enh	Serial, Parallel	Input	Enhancement mode. When asserted low ("0"), enhancement register bits are functional.

Note 1: V_{DD} pins 1, 11, 12, 23, 33, and 35 are connected by diodes and must be supplied with the same positive voltage level.

Note 2: V_{DD} pins 31 and 38 are used to enable test modes and should be left floating.

Figure 3. Looking into the device PIN 42 - $f_{\rm r}$

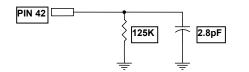




Table 2. Absolute Maximum Ratings

Symbol	Parameter/Conditions	Min	Max	Units
V _{DD}	Supply voltage	-0.3	4.0	V
Vı	Voltage on any input	-0.3	V _{DD} + 0.3	V
I,	DC into any input	-10	+10	mA
lo	DC into any output	-10	+10	mA
T _{stg}	Storage temperature range	-65	150	°C

Table 3. Operating Ratings

Symbol	Parameter/Conditions	Min	Max	Units
V _{DD}	Supply voltage	2.85	3.15	V
T _A	Operating ambient temperature range	-40	85	°C

Table 4. ESD Ratings

Symbol	Parameter/Conditions	Level	Units		
V_{ESD}	ESD voltage (Human Body Model) – Note 1	1000	V		

Note 1: Periodically sampled, not 100% tested. Tested per MIL-STD-883, M3015 C2

Electrostatic Discharge (ESD) Precautions

When handling this UTSi device, observe the same precautions that you would use with other ESDsensitive devices. Although this device contains circuitry to protect it from damage due to ESD, precautions should be taken to avoid exceeding the rating specified in Table 4.

Latch-Up Avoidance

Unlike conventional CMOS devices, UTSi CMOS devices are immune to latch-up.



Table 5. DC Characteristics

Symbol	Parameter	Test Program Name	Conditions	Min	Тур	Max	Units
I _{DD}	Operational supply current; Prescaler enabled 2 GHz center frequency with 10 MHz reference input.	IDD_T_oper_at_2 GHz	V _{DD} = 2.85 to 3.15 V		25		mA
Digital Inputs:	All except f_r , R_0 , F_{in} , \overline{F}_{in}						
V _{IH}	High level input voltage	LEVELS_"xxx"_VIH(V) where "xxx" is name of pin being tested	V _{DD} = 2.85 to 3.15 V	0.7 x V _{DD}			V
V _{IL}	Low level input voltage	LEVELS_"xxx"_VIL(V) where "xxx" is name of pin being tested	V _{DD} = 2.85 to 3.15 V			0.3 x V _{DD}	V
I _{IH}	High level input current	IIH_"xxx"_(A) where "xxx" is name of pin being tested	V _{IH} = V _{DD} = 3.15 V			+1	μA
IIL	Low level input current	IIL_"xxx"_(A) where "xxx" is name of pin being tested	V _{IL} = 0, V _{DD} = 3.15 V	-1			μA
Reference Div	ider input: fr						
I _{IHR}	High level input current	IIH_FR_(A)	V _{IH} = V _{DD} = 3.15 V			+100	μA
I _{ILR}	Low level input current	IIL_FR_(A)	V _{IL} = 0, V _{DD} = 3.15 V	-100			μA
R0 Input (Pull-	up Resistor): R ₀						
I _{IHR}	High level input current	IIH_R0_(A)	V _{IH} = V _{DD} = 3.15 V			+5	μA
I _{ILR}	Low level input current	IIL_R0_(A)	V _{IL} = 0, V _{DD} = 3.15 V	-5			μA
Counter and p	hase detector outputs: f _c , f _p .			11		11	
V _{OLD}	Output voltage LOW	LEVELS_"xxx"_VOL(V) where "xxx" is name of pin being tested	I _{out} = 6 mA			0.4	V
V _{OHD}	Output voltage HIGH	LEVELS_"xxx"_VOH(V) where "xxx" is name of pin being tested	I _{out} = -3 mA	V _{DD} - 0.4			V
Lock detect ou	tputs: Cext, LD						
V _{OLC}	Output voltage LOW, Cext	LEVELS_CEXT_VOL(V)	I _{out} = 0.1 mA			0.4	V
V _{OHC}	Output voltage HIGH, Cext	LEVELS_CEXT_VOH(V)	I _{out} = -0.1 mA	V _{DD} - 0.4			V
V _{OLLD}	Output voltage LOW, LD	LEVELS_CEXT_VOL(V)	I _{out} = 1 mA			0.4	V
Charge Pump	output: CP						
I_{CP} - Source	Drive current	CP_src_at_0.5 VDD (A)	$V_{CP} = V_{DD} / 2$	-2.6	-2	-1.4	mA
I_{CP} – Sink	Drive current	CP_snk_at_0.5 VDD (A)	$V_{CP} = V_{DD} / 2$	1.4	2	2.6	mA
I _{CPL}	Leakage current	CP_lkg_PD_DX (A)	$1.0 V < V_{CP} < V_{DD} - 1.0 V$	-1		1	μA
I _{CP} – Source vs. I _{CP} Sink	Sink vs. source mismatch	CP_srcvsnk_at_0.5 VDD	$V_{CP} = V_{DD} / 2,$ $T_{A} = 25^{\circ} C$			15	%
$I_{CP} \text{ vs. } V_{CP}$	Output current magnitude variation vs. voltage	CP_snk_var, CP_src_var	$V < V_{CP} < V_{DD} -$ 1.0 V T _A = 25° C			15	%



Table 6. AC Characteristics

Symbol	Parameter	Test Program Name	Conditions	Min	Мах	Units
Control Interfac	e and Latches (see Figures 4, 5, 6)					•
f _{Clk}	Serial data clock frequency	(Note 1)			10	MHz
t _{ClkH}	Serial clock HIGH time	t_clkH (s)		30		ns
t _{⊂lkL}	Serial clock LOW time	t_clkL (s)		30		ns
t _{DSU}	Sdata set-up time after Sclk rising edge, D[7:0] set-up time to M1_WR, M2_WR, A_WR, E_WR rising edge	t_dsu_"xxx" (s) where "xxx" is name of pin being tested		10		ns
t _{dhld}	Sdata hold time after Sclk rising edge, D[7:0] hold time to M1_WR, M2_WR, A_WR rising edge	t_dhid_"xxx" (s) where "xxx" is name of pin being tested		10		ns
t _{PW}	S_WR, M1_WR, M2_WR, A_WR, E_WR pulse width	t_pw_"xxx" (s) where "xxx" is name of pin being tested		30		ns
t _{cwR}	Sclk rising edge to S_WR rising edge. S_WR, M1_WR, M2_WR, A_WR falling edge to Hop_WR rising edge	t_cwr_"xxx" (s) where "xxx" is name of pin being tested		30		ns
t _{CE}	Sclk falling edge to E_WR transition	t_ce (s)		30		ns
t _{wrc}	S_WR falling edge to Sclk rising edge. Hop_WR falling edge to S_WR, M1_WR, M2_WR, A_WR rising edge	t_wrc_"xxx" (s) where "xxx" is name of pin being tested		30		ns
t _{EC}	E_WR transition to Sclk rising edge	t_ec (s)		30		ns
Main Divider (In	ncluding Prescaler)					
F _{in}	Operating frequency	RF_sens		200	2200	MHz
P _{Fin}	Input level range	RF_sens	External AC coupling	0	5	dBm
Main Divider (P	rescaler Bypassed)					
F _{in}	Operating frequency			20	220	MHz
P _{Fin}	Input level range		External AC coupling	-5	5	dBm
Reference Divid	der					
f _r	Operating frequency	Fc_sens	(Note 3)		100	MHz
P _{fr}	Reference input power (Note 2)	Fc_sens	Single ended input	-2		dBm
Phase Detector	·					
f _c	Comparison frequency		(Note 3)		20	MHz

Note 1: Fclk is verified during the functional pattern test. Serial programming sections of the functional pattern are clocked at 10 MHz to verify Fclk specification.

Note 2: CMOS logic levels can be used to drive reference input if DC coupled. Voltage input needs to be a minimum of 0.5Vp-p.

Note 3: Parameter is guaranteed through characterization only and is not tested.



Functional Description

The PE9601 consists of a prescaler, counters, a phase detector, a charge pump and control logic. The dual modulus prescaler divides the VCO frequency by either 10 or 11, depending on the value of the modulus select. Counters "R" and "M" divide the reference and prescaler output, respectively, by integer values stored in a 20-bit register. An additional counter ("A") is used in the

modulus select logic. The phase-frequency detector generates up and down frequency control signals, which are implemented as a pulse width modulated current by the charge pump. The control logic includes a selectable chip interface. Data can be written via serial bus, parallel bus, or hardwired direct to the pins. There are also various operational and test modes and lock detect.

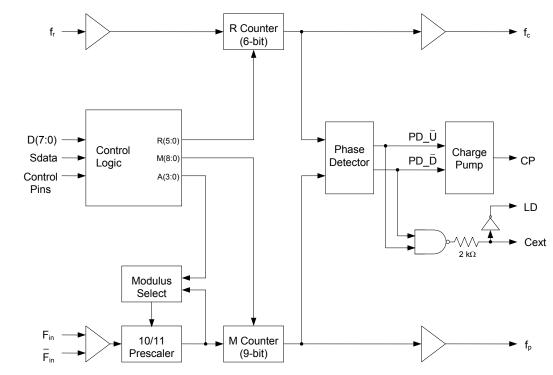


Figure 4. Functional Block Diagram



Main Counter Chain

The main counter chain divides the RF input frequency, F_{in} , by an integer derived from the user defined values in the "M" and "A" counters. It is composed of the 10/11 dual modulus prescaler, modulus select logic, and 9 bit M counter. Setting Pre_en "low" enables the 10/11 prescaler. Setting Pre_en "high" allows F_{in} to bypass the prescaler and powers down the prescaler.

The output from the main counter chain, f_p , is related to the VCO frequency, F_{in} , by the following equation:

 $f_p = F_{in} / [10 \times (M + 1) + A]$ (1) where $A \le M + 1, M \ne 0$

When the loop is locked, F_{in} is related to the reference frequency, f_r , by the following equation:

 $F_{in} = [10 \ x \ (M+1) + A] \ x \ (f_r / (R+1))$ (2) where $A \le M + 1, \ M \ne 0$

A consequence of the upper limit on A is that F_{in} must be greater than or equal to 90 x (f_r / (R+1)) to obtain contiguous channels. Programming the M Counter with the minimum value of "1" will result in a minimum M Counter divide ratio of "2".

In Direct Interface Mode, main counter inputs M_7 and M_8 are internally forced low.

Reference Counter

The reference counter chain divides the reference frequency, f_r , down to the phase detector comparison frequency, f_c .

The output frequency of the 6 bit R Counter is related to the reference frequency by the following equation:

(3)

 $f_c = f_r / (R + 1)$ where $R \ge 0$

Note that programming R equal to "0" will pass the reference frequency, f_r , directly to the phase detector.

In Direct Interface Mode, R Counter inputs R_4 and R_5 are internally forced low ("0").

Register Programming

Parallel Interface Mode

Parallel Interface Mode is selected by setting the Bmode input "low" and the Smode input "low".

Parallel input data, D[7:0], are latched in a parallel fashion into one of three, 8-bit primary register sections on the rising edge of M1_WR, M2_WR, or A_WR per the mapping shown in Table 7 on page 10. The contents of the primary register are transferred into a secondary register on the rising edge of Hop_WR according to the timing diagram shown in Figure 4. Data are transferred to the counters as shown in Table 7 on page 10.

The secondary register acts as a buffer to allow rapid changes to the VCO frequency. This double buffering for "ping-pong" counter control is programmed via the FSELP input. When FSELP is "high", the primary register contents set the counter inputs. When FSELP is "low", the secondary register contents are utilized.

Parallel input data, D[7:0], are latched into the enhancement register on the rising edge of E_WR according to the timing diagram shown in Figure 4. This data provides control bits as shown in Table 8 on page 10 with bit functionality enabled by asserting the Enh input "low".

Serial Interface Mode

Serial Interface Mode is selected by setting the Bmode input "low" and the Smode input "high".

While the E_WR input is "low" and the S_WR input is "low", serial input data (Sdata input), B_0 to B_{19} , are clocked serially into the primary register on the rising edge of Sclk, MSB (B_0) first. The contents from the primary register are transferred into the secondary register on the rising edge of either S_WR or Hop_WR according to the timing diagram shown in Figures 4-5. Data are transferred to the counters as shown in Table 7 on page 10.

The double buffering provided by the primary and secondary registers allows for "ping-pong" counter control using the FSELS input. When FSELS is "high", the primary register contents set the counter inputs. When FSELS is "low", the secondary register contents are utilized.

While the E_WR input is "high" and the S_WR input is "low", serial input data (Sdata input), B₀ to B₇, are clocked serially into the enhancement register on the rising edge of Sclk, MSB (B₀) first. The enhancement register is double buffered to prevent



inadvertent control changes during serial loading, with buffer capture of the serially entered data performed on the falling edge of E_WR according to the timing diagram shown in Figure 5. After the falling edge of E_WR, the data provide control bits as shown in Table 8 with bit functionality enabled by asserting the Enh input "low".

Direct Interface Mode

Direct Interface Mode is selected by setting the Bmode input "high".

Counter control bits are set directly at the pins as shown in Table 7. In Direct Interface Mode, main counter inputs M_7 and M_8 , and R Counter inputs R_4 and R_5 are internally forced low ("0").

Interface Mode	Enh	Bmode	Smode	R₅	R ₄	M ₈	M ₇	Pre_en	M ₆	M₅	M₄	M₃	M ₂	M ₁	Mo	R₃	R ₂	R ₁	R₀	A ₃	A ₂	A ₁	A ₀
Parallel	1	0	0	M2_V	M2_WR rising edge load				M1_WR rising edge load						A_WR rising edge load								
				D ₃	D_2	D_1	D_0	D ₇	D_6	D_5	D_4	D ₃	D_2	D ₁	D_0	D ₇	D_6	D_5	D ₄	D_3	D_2	D_1	D ₀
Serial*	1	0	1	B ₀	B ₁	B ₂	B ₃	B ₄	B ₅	B ₆	B ₇	B ₈	B ₉	B ₁₀	B ₁₁	B ₁₂	B ₁₃	B ₁₄	B ₁₅	B ₁₆	B ₁₇	B ₁₈	B ₁₉
Direct	1	1	Х	0	0	0	0	Pre_en	M ₆	M_5	M_4	M ₃	M ₂	M_1	M ₀	R ₃	R ₂	R ₁	R ₀	A ₃	A ₂	A ₁	A ₀

*Serial data clocked serially on Sclk rising edge while E_WR "low" and captured in secondary register on S_WR rising edge.



(last in) LSB

Table 8. Enhancement Register Programming

Interface Mode	Enh	Bmode	Smode	Reserved	Reserved	Reserved	Power down	Counter Ioad	MSEL output	Prescaler output	$f_c, f_p \overline{OE}$
Parallel	0	х	0	E_WR rising edge load							
Falaliei				D ₇	D ₆	D ₅	D ₄	D ₃	D ₂	D ₁	Do
Serial*	0	х	1	B ₀	B ₁	B ₂	B ₃	B ₄	B ₅	B_6	B ₇

*Serial data clocked serially on Sclk rising edge while E_WR "high" and captured in the double buffer on E_WR falling edge.







Figure 5. Parallel Interface Mode Timing Diagram

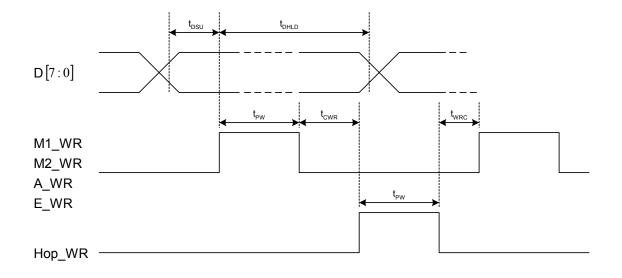
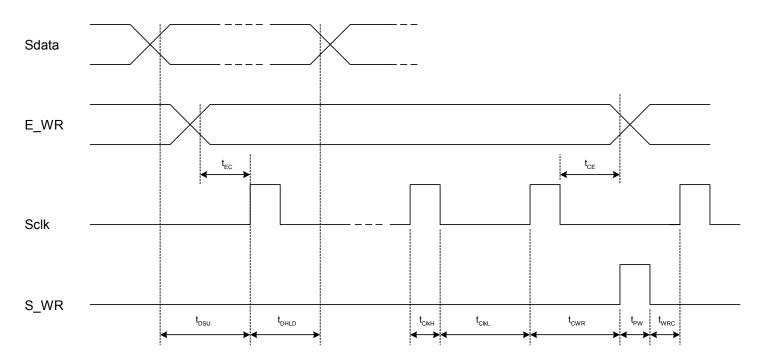


Figure 6. Serial Interface Mode Timing Diagram







Enhancement Register

The functions of the enhancement register bits are shown below with all bits active "high".

Bit Function		Description		
Bit 0	Reserved**			
Bit 1	Reserved**			
Bit 2	Reserved**			
Bit 3	Power down	Power down of all functions except programming interface.		
Bit 4	Counter load	Immediate and continuous load of counter programming as directed by the $\overline{\text{Bmode}}$ and Smode inputs.		
Bit 5	MSEL output	Drives the internal dual modulus prescaler modulus select (MSEL) onto the Dout output.		
Bit 6	Prescaler output	Drives the raw internal prescaler output (fmain) onto the Dout output.		
Bit 7	$f_p, f_c \overline{OE}$	f_{p} , f_{c} outputs disabled.		

Table 9.	Enhancement	Register	Bit Functionality
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** Program to 0

Phase Detector

The phase detector is triggered by rising edges from the main Counter (f_p) and the reference counter (f_c) . It has two outputs, namely PD_U, and PD_D. If the divided VCO leads the divided reference in phase or frequency $(f_p \text{ leads } f_c)$, PD_D pulses "high". If the divided reference leads the divided VCO in phase or frequency $(f_r \text{ leads } f_p)$, PD_U pulses "high". The width of either pulse is directly proportional to phase offset between the two input signals, f_p and f_c .

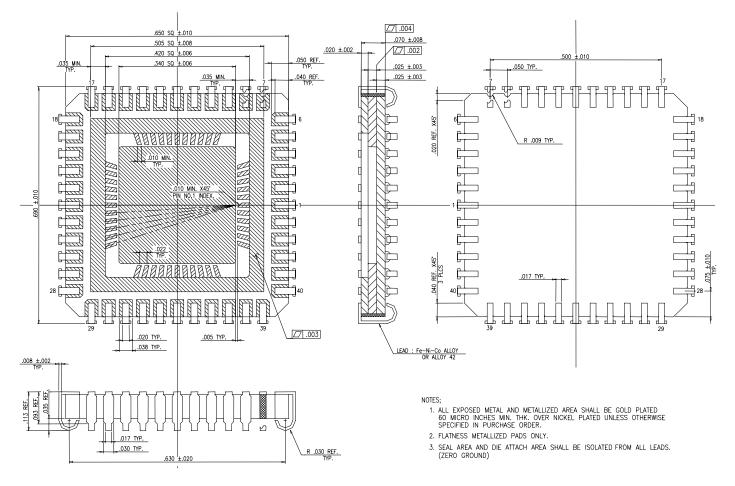
The signals from the phase detector couple directly to a charge pump. $PD_{\overline{U}}$ controls a current source at pin CP with constant amplitude and pulse duration approximately the same as $PD_{\overline{U}}$. $PD_{\overline{D}}$ similarly drives a current sink at pin CP. The

current pulses from pin CP are low pass filtered externally and then connected to the VCO tune voltage. $PD_{\overline{U}}$ pulses result in a current source, which increases the VCO frequency and $PD_{\overline{D}}$ results in a current sink, which decreases VCO frequency.

A lock detect output, LD is also provided, via the pin Cext. Cext is the logical "OR" of PD_U and PD_D waveforms, which is driven through a series 2 kohm resistor. Connecting Cext to an external shunt capacitor provides integration. Cext also drives the input of an internal inverting comparator with an open drain output. Thus LD is an "NOR" function of PD_U and PD_D.



Figure 7. Package Drawing



All dimensions are in mils



Table 10. Ordering Information

Order Code	Part Marking	Description	Package	Shipping Method	
9601-11	PE9601	Flight Units	44-pin CQFJ	40 units / Tray	
9601-00	PE9601EK		Evaluation Board	1 / Box	

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Data Sheet Identification

Advance Information

The product is in a formative or design stage. The data sheet contains design target specifications for product development. Specifications and features may change in any manner without notice.

Preliminary Specification

The data sheet contains preliminary data. Additional data may be added at a later date. Peregrine reserves the right to change specifications at any time without notice in order to supply the best possible product.

Product Specification

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